

### N-Channel Power MOSFET 6A, 900Volts

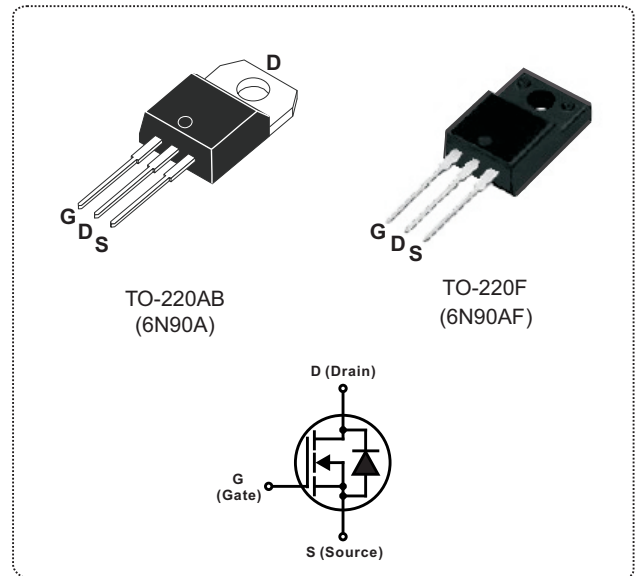
#### DESCRIPTION

The Nell **6N90** is a three-terminal silicon device with current conduction capability of 6A, fast switching speed, low on-state resistance, breakdown voltage rating of 900V, and max. threshold voltage of 5 volts.

They are designed for use in applications such as switched mode power supplies, DC to DC converters, **PWM** motor controls, bridge circuits and general purpose switching applications.

#### FEATURES

- $R_{DS(ON)} = 2.3\Omega @ V_{GS} = 10V$
- Ultra low gate charge(40nC max.)
- Low reverse transfer capacitance ( $C_{RSS} = 11pF$  typical)
- Fast switching capability
- 100% avalanche energy specified
- Improved dv/dt capability
- 150°C operation temperature



#### PRODUCT SUMMARY

$I_D$ (A)	6
$V_{DSS}$ (V)	900
$R_{DS(ON)}$ ( $\Omega$ )	2.3 @ $V_{GS} = 10V$
$Q_G$ (nC) max.	40

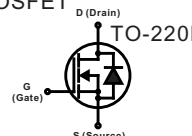
#### ABSOLUTE MAXIMUM RATINGS ( $T_C = 25^\circ C$ unless otherwise specified)

SYMBOL	PARAMETER	TEST CONDITIONS	VALUE	UNIT	
$V_{DSS}$	Drain to Source voltage	$T_J = 25^\circ C$ to $150^\circ C$	900	V	
$V_{DGR}$	Drain to Gate voltage	$R_{GS} = 20K\Omega$	900		
$V_{GS}$	Gate to Source voltage		$\pm 30$		
$I_D$	Continuous Drain Current	$T_C = 25^\circ C$	6	A	
		$T_C = 100^\circ C$	3.8		
$I_{DM}$	Pulsed Drain current(Note 1)		24		
$I_{AR}$	Avalanche current(Note 1)		6		
$E_{AR}$	Repetitive avalanche energy(Note 1)	$I_{AR} = 6A, R_{GS} = 50\Omega, V_{GS} = 10V$	16.7	mJ	
$E_{AS}$	Single pulse avalanche energy(Note 2)	$I_{AS} = 6A, L = 34mH$	650		
dv/dt	Peak diode recovery dv/dt(Note 3)		4.5	V / ns	
$P_D$	Total power dissipation	$T_C = 25^\circ C$	TO-220AB	167	W
			TO-220F	56	
	Linear derating factor above $T_C = 25^\circ C$	$T_C = 25^\circ C$	TO-220AB	1.43	$^\circ C/W$
			TO-220F	0.48	
$T_J$	Operation junction temperature		-55 to 150	$^\circ C$	
$T_{STG}$	Storage temperature		-55 to 150		
$T_L$	Maximum soldering temperature, for 10 seconds	1.6mm from case	300		
	Mounting torque, #6-32 or M3 screw		10 (1.1)	lbf-in (N·m)	

Note: 1. Repetitive rating: pulse width limited by junction temperature.  
 2.  $I_{AS} = 6A, L = 34mH, V_{DD} = 50V, R_{GS} = 25\Omega$ , starting  $T_J = 25^\circ C$ .  
 3.  $I_{SD} \leq 6A, di/dt \leq 200A/\mu s, V_{DD} \leq V_{(BR)DSS}$ , starting  $T_J = 25^\circ C$ .

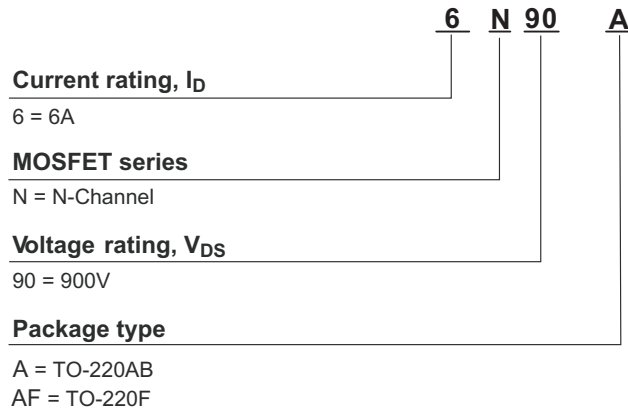
THERMAL RESISTANCE						
SYMBOL	PARAMETER		MIN.	TYP.	MAX.	UNIT
$R_{th(j-c)}$	Thermal resistance, junction to case	TO-220AB			0.75	°C/W
		TO-220F			2.25	
$R_{th(j-a)}$	Thermal resistance, junction to ambient	TO-220AB			62.5	
		TO-220F			62.5	

ELECTRICAL CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ unless otherwise specified)							
SYMBOL	PARAMETER	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
◎ OFF CHARACTERISTICS							
$V_{(BR)DSS}$	Drain to source breakdown voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}$	900			V	
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown voltage temperature coefficient	$I_D = 250\mu\text{A}, V_{DS} = V_{GS}$		1.07		V/°C	
$I_{DSS}$	Drain to source leakage current	$V_{DS} = 900\text{V}, V_{GS} = 0\text{V}, T_C = 25^\circ\text{C}$			10	$\mu\text{A}$	
		$V_{DS} = 720\text{V}, V_{GS} = 0\text{V}, T_C = 125^\circ\text{C}$			100		
$I_{GSS}$	Gate to source forward leakage current	$V_{GS} = 30\text{V}, V_{DS} = 0\text{V}$			100	nA	
	Gate to source reverse leakage current	$V_{GS} = -30\text{V}, V_{DS} = 0\text{V}$			-100		
◎ ON CHARACTERISTICS							
$R_{DS(ON)}$	Static drain to source on-state resistance	$V_{GS} = 10\text{V}, I_D = 3\text{A}$		1.95	2.3	$\Omega$	
$V_{GS(TH)}$	Gate threshold voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	3		5	V	
$g_{FS}$	Forward transconductance	$V_{DS} = 50\text{V}, I_D = 3\text{A}$		5.5		S	
◎ DYNAMIC CHARACTERISTICS							
$C_{ISS}$	Input capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$		1360	1770	pF	
$C_{OSS}$	Output capacitance				110		145
$C_{RSS}$	Reverse transfer capacitance				11		15
◎ SWITCHING CHARACTERISTICS							
$t_{d(ON)}$	Turn-on delay time	$V_{DD} = 450\text{V}, V_{GS} = 10\text{V}$ $I_D = 6\text{A}, R_{GS} = 25\Omega$ (Note 1,2)		35	80	ns	
$t_r$	Rise time				90		190
$t_{d(OFF)}$	Turn-off delay time				55		120
$t_f$	Fall time				60		130
$Q_G$	Total gate charge	$V_{DD} = 720\text{V}, V_{GS} = 10\text{V}$ $I_D = 6\text{A},$ (Note 1,2)		30	40	nC	
$Q_{GS}$	Gate to source charge				9.0		
$Q_{GD}$	Gate to drain charge (Miller charge)				12		

SOURCE TO DRAIN DIODE RATINGS AND CHARACTERISTICS ( $T_C = 25^\circ\text{C}$ unless otherwise specified)						
SYMBOL	PARAMETER	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{SD}$	Diode forward voltage	$I_{SD} = 6\text{A}, V_{GS} = 0\text{V}$			1.4	V
$I_S$ ( $I_{SD}$ )	Continuous source to drain current	Integral reverse P-N junction diode in the MOSFET 			6	A
$I_{SM}$	Pulsed source current				24	
$t_{rr}$	Reverse recovery time	$I_{SD} = 6\text{A}, V_{GS} = 0\text{V},$ $dI_F/dt = 100\text{A}/\mu\text{s}$		630		ns
$Q_{rr}$	Reverse recovery charge			6.9		$\mu\text{C}$

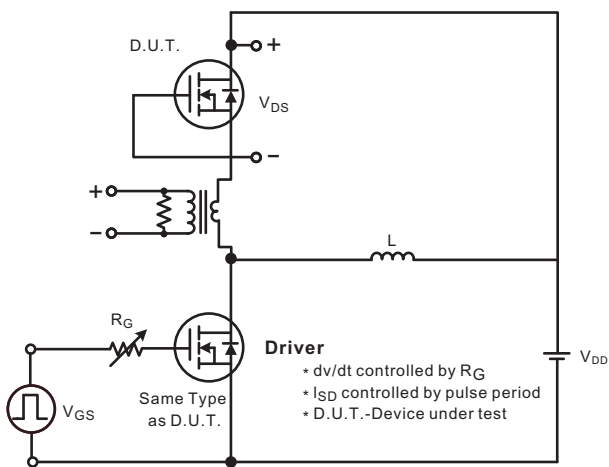
Note: 1. Pulse test: Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .  
2. Essentially independent of operating temperature.

**ORDERING INFORMATION SCHEME**

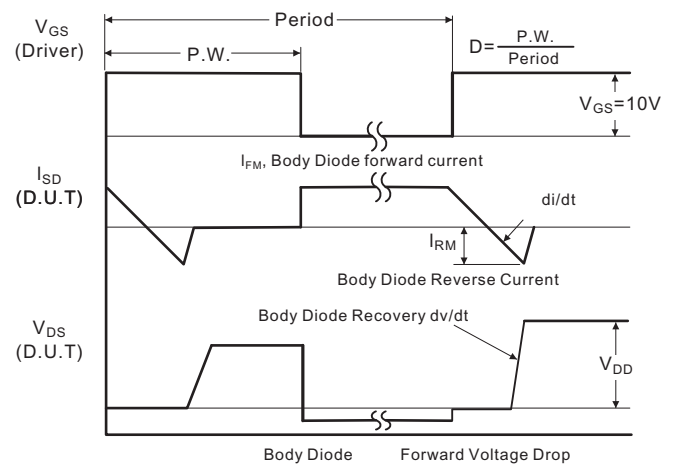


**TEST CIRCUITS**

**Fig.1A Peak diode recovery dv/dt test circuit**



**Fig.1B Peak diode recovery dv/dt waveforms**



■ TEST CIRCUIT(Cont.)

Fig.2A Switching test circuit

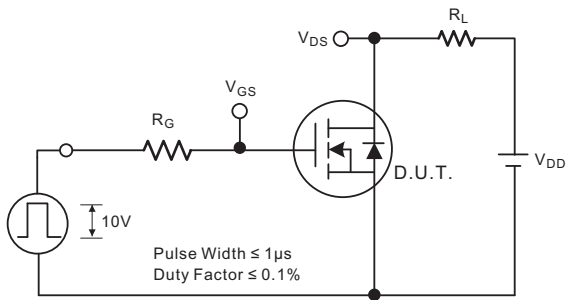


Fig.2B Switching Waveforms

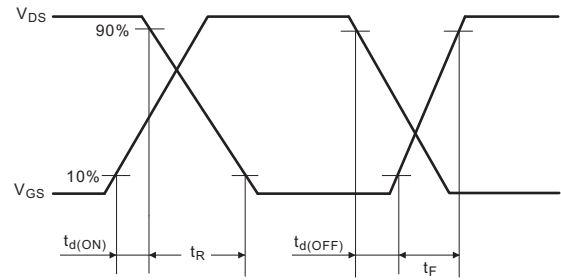


Fig.3A Gate charge test circuit

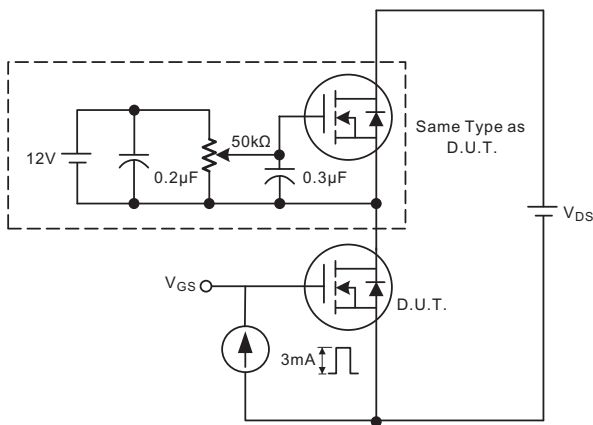


Fig.3B Gate charge waveform

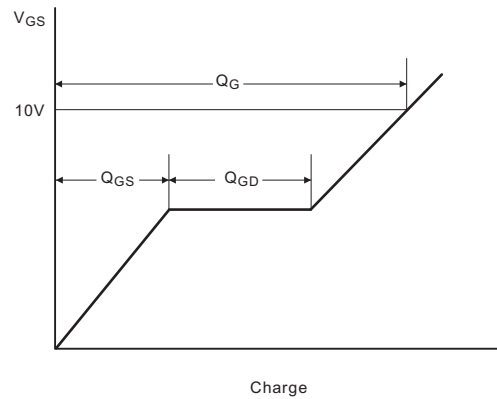


Fig.4A Unclamped Inductive switching test circuit

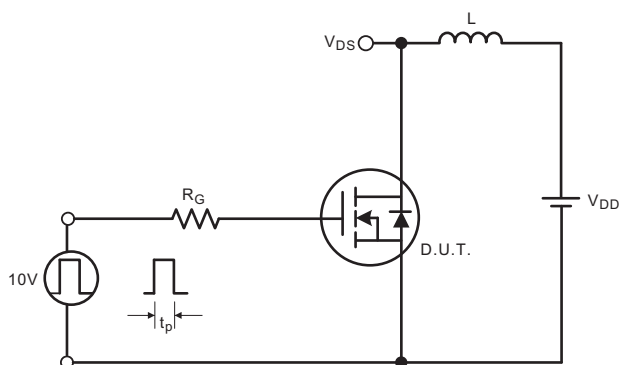
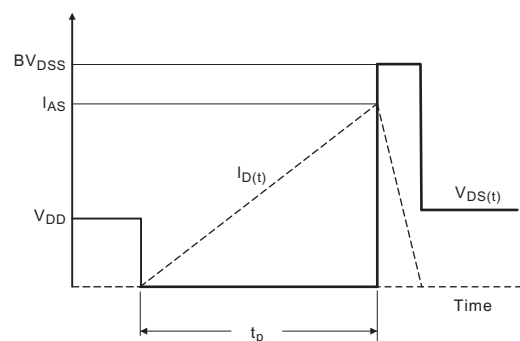
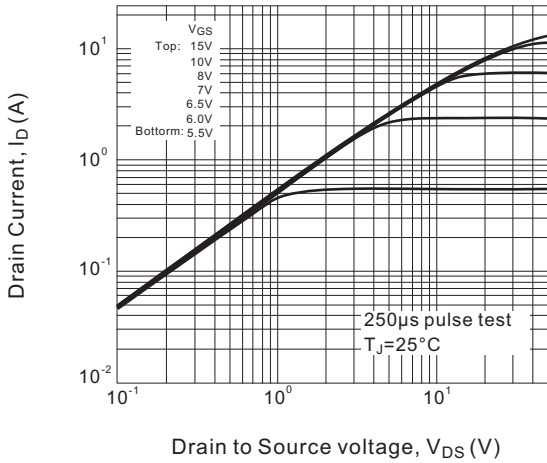


Fig.4B Unclamped Inductive switching waveforms

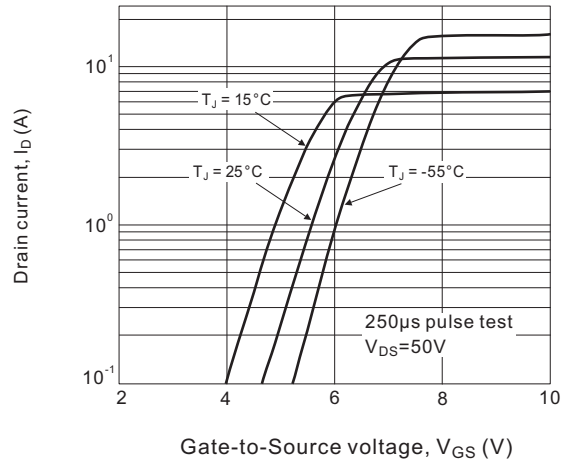


### ■ TYPICAL CHARACTERISTICS

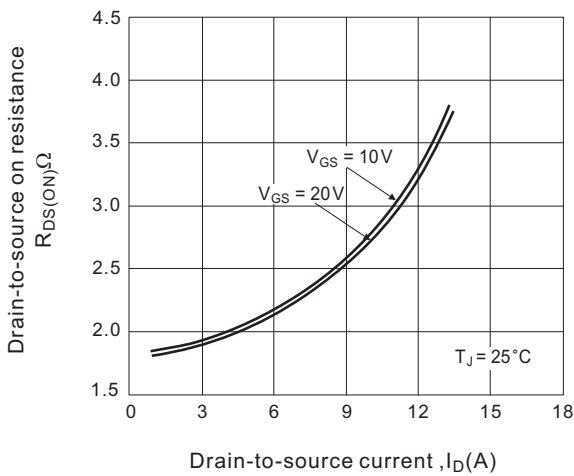
**Fig.1 Typical output characteristics**



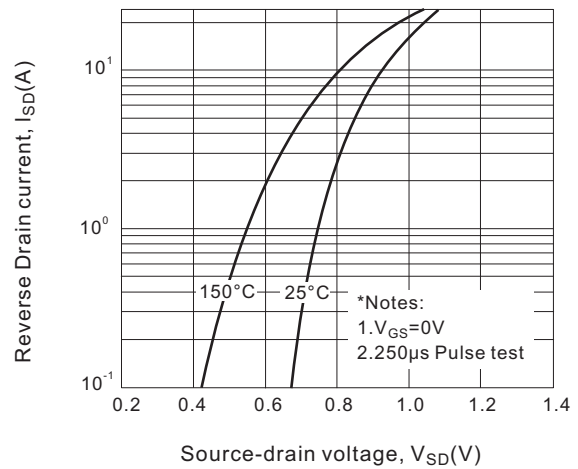
**Fig.2 Typical transfer characteristics**



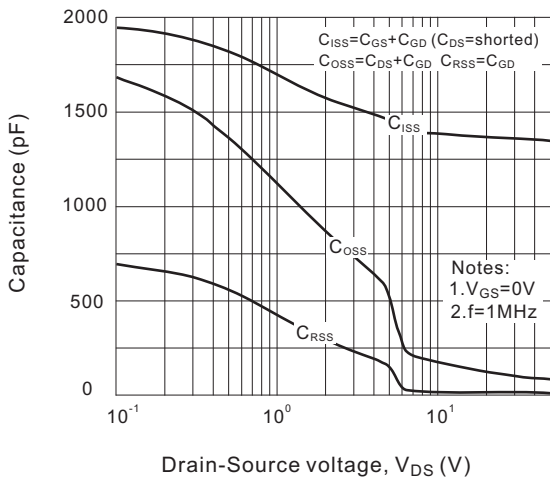
**Fig.3 On-resistance variation vs. drain current and gate voltage**



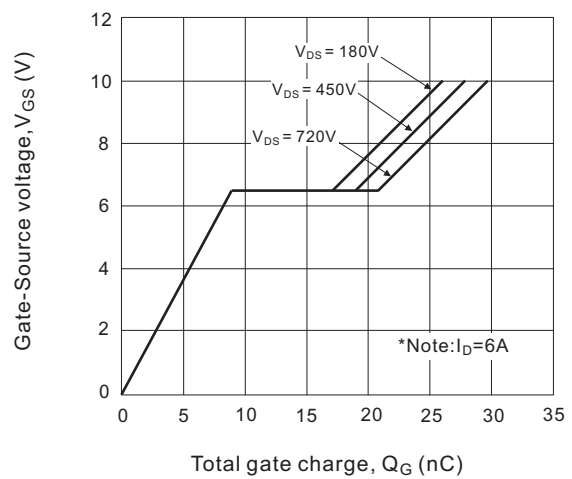
**Fig.4 Body diode forward voltage variation with source current and temperature**



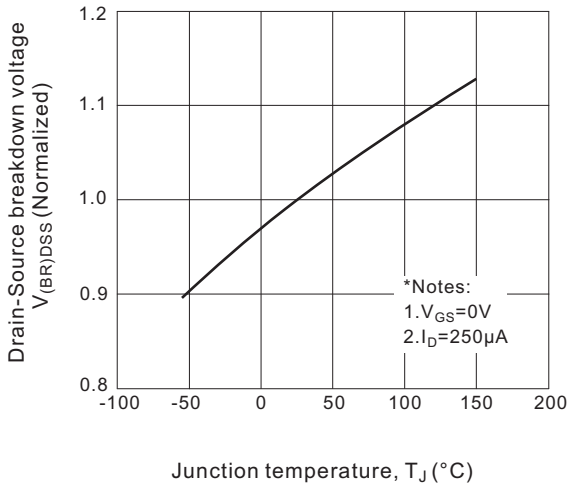
**Fig.5 Typical capacitance characteristics**



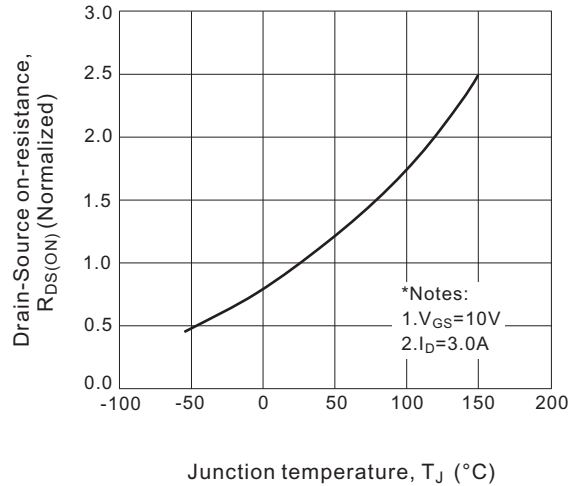
**Fig.6 Typical gate charge characteristics**



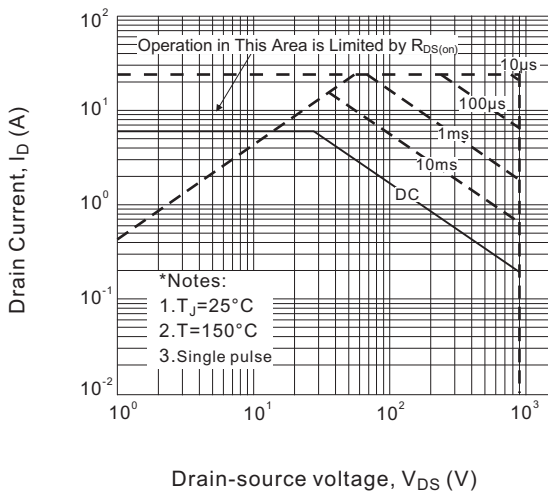
**Fig.7 Breakdown voltage variation vs. Junction temperature**



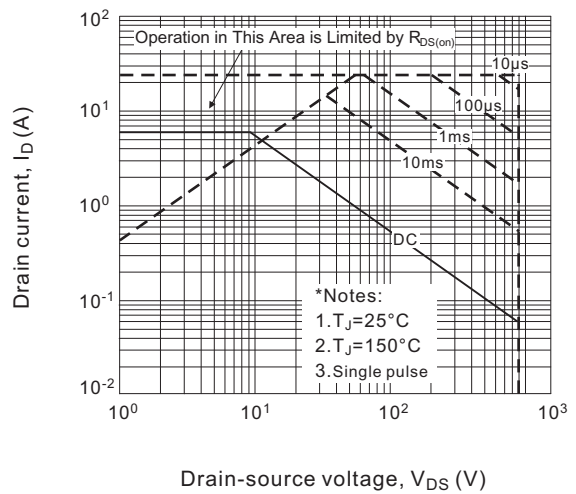
**Fig.8 On-resistance variation vs. Junction temperature**



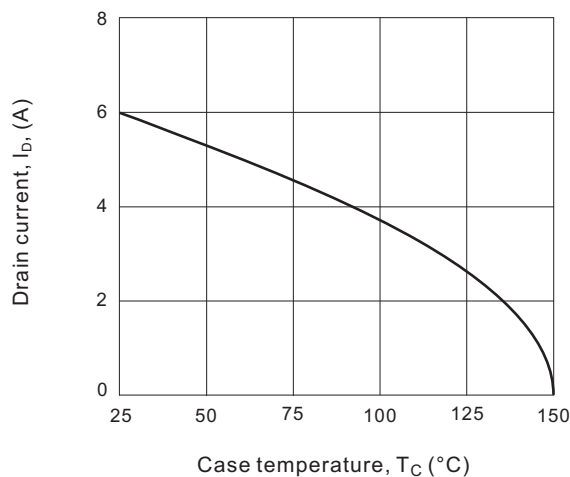
**Fig.9 Maximum safe operating area for 6N90A**



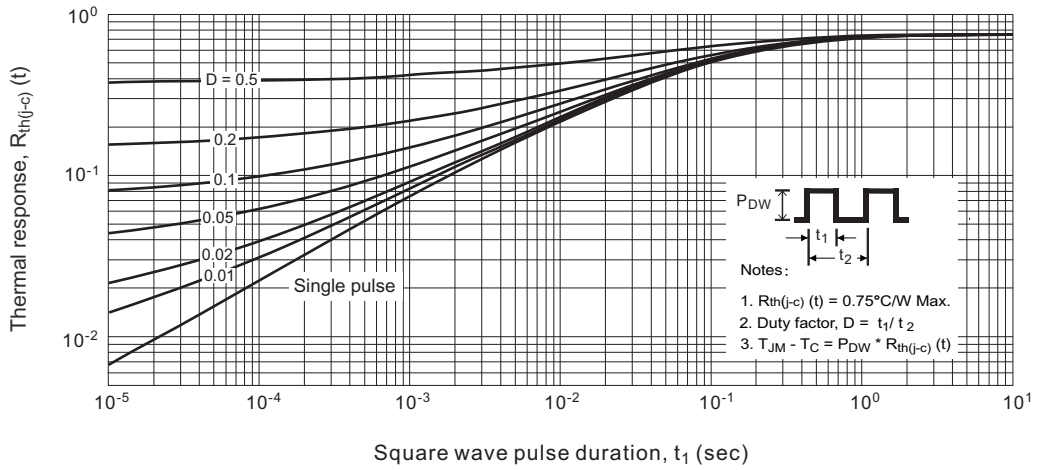
**Fig.9-2 Maximum safe operating area for 6N90AF**



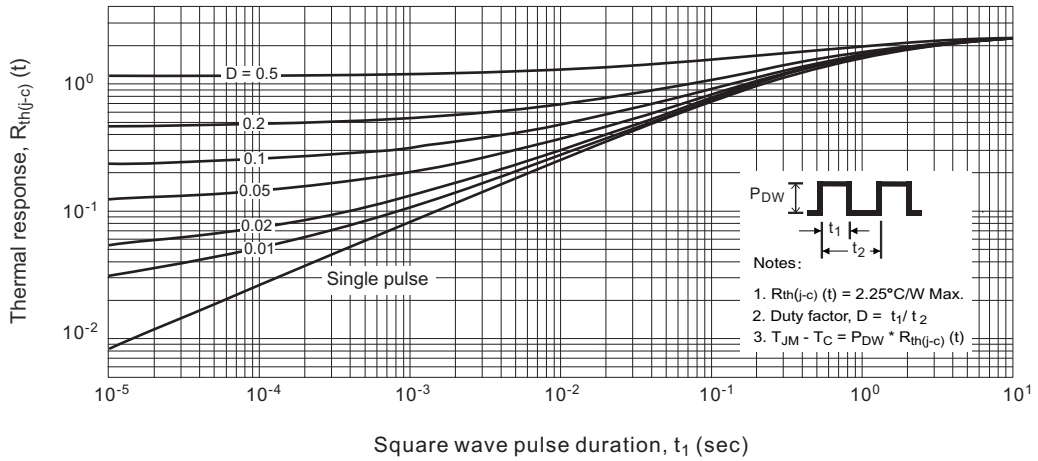
**Fig.10 Maximum drain current vs. Case temperature**



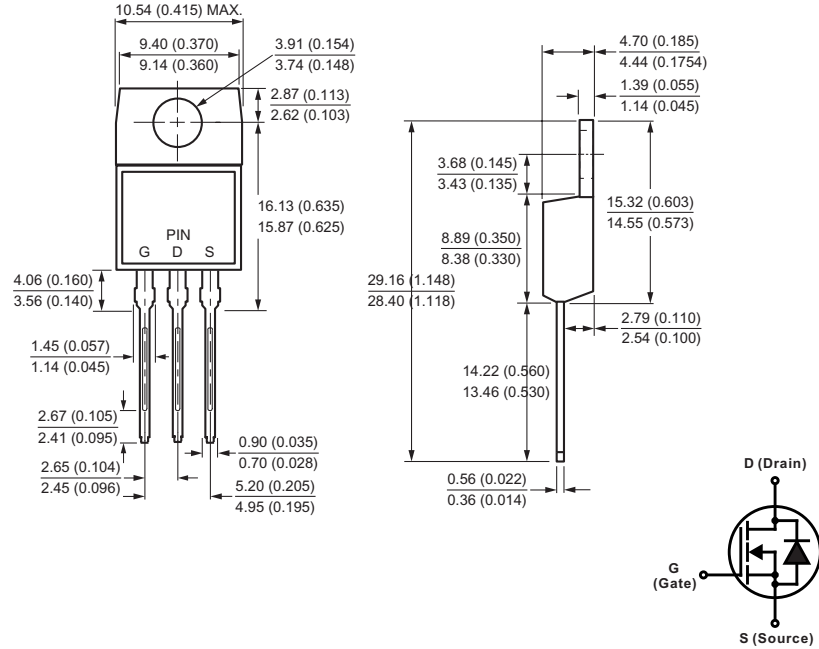
**Fig.11 Transient thermal response curve for 6N90A**



**Fig.12 Transient thermal response curve for 6N90AF**

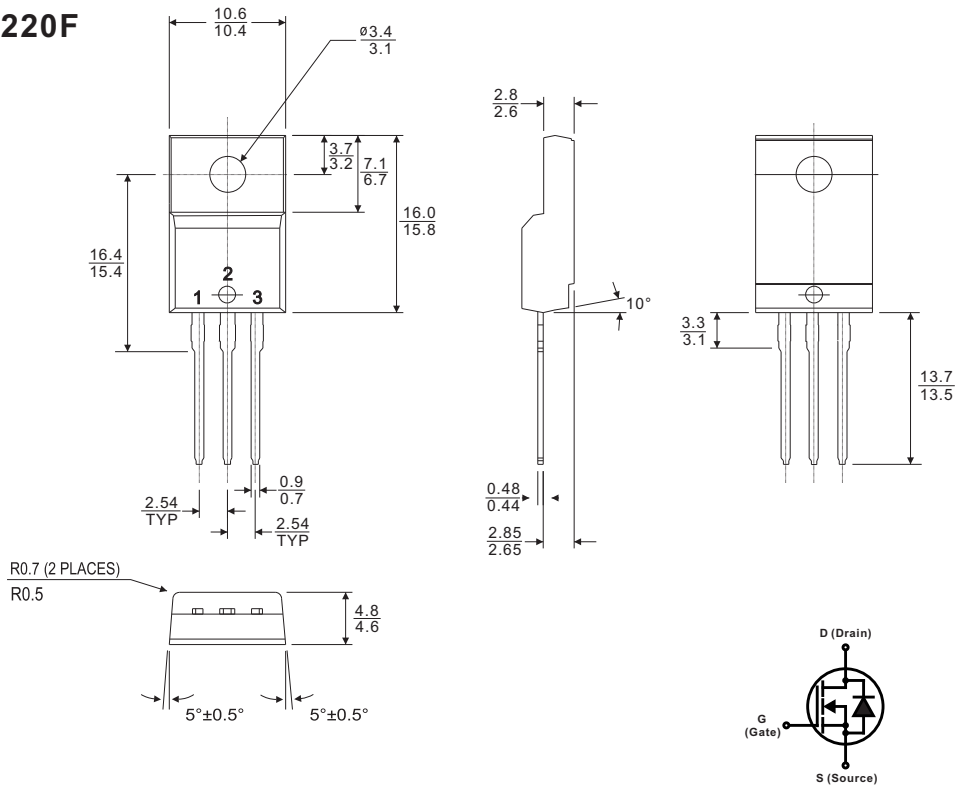


**TO-220AB**



All dimensions in millimeters(inches)

**TO-220F**



All dimensions in millimeters